

SCE User Guide

(CRAY T90™ Series)

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SCE USER GUIDE

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Description of this Document

This document describes the CRAY T90 series System Configuration Environment (SCE) application used to configure CRAY T90 series mainframes. This document also describes how to use SCE.

This document is one component of the SCE documentation set, which also includes the following document:

SCE Interface Reference, publication number HDM-182-B.

The *SCE Interface Reference* describes the SCE interface and all available menu button commands.

SCE OVERVIEW

The System Configuration Environment (SCE) is X Window System software that runs in a maintenance workstation (MWS) to handle the CRAY T90 series mainframe configuration tasks. This application:

- Creates and manages the mainframe logical configuration (Refer to the following “Logical Configuration” description for more detail.)
- Creates and manages the mainframe partitions (Refer to the “Partitioning” description on page 2 for more detail.)
- Degrades memory to enable you to continue system operation or perform system maintenance in the presence of memory system failures (Refer to “Memory Degradation” on page 6 for more detail.)
- Creates and manages a table of the flawed memory module chips that SCE uses to substitute spare chips for the flawed chips (Refer to the “Spare Chip Memory Management” description on page 17 for more detail.)



Logical Configuration

CRAY T90 series mainframes use logical configuration: the configuration is set by manipulating soft switch values rather than by physically rearranging the hardware. Logical configuration enables you to include or exclude modules from a system configuration without powering down any modules or the mainframe. This enables you to perform maintenance in one part of the system while another part runs the operating system (OS). It also enables you to reconfigure areas of the system without affecting other areas.

SCE issues maintenance channel functions to create and manage the logical configuration. These functions manipulate sanity codes in the sanity tree for modules in the mainframe. The presence or absence of a sanity code for a module in the mainframe is the logical equivalent of powering the module up or down. Refer to the *Maintenance Channel* document, publication number HTM-006-B, for more information about sanity codes and the sanity tree.

NOTE: All configuration selections apply symmetrically within the CPUs in the selected partition; for example, selecting 4-bank mode within a CPU means that all requests on all memory ports use 4-bank addressing. It is not possible to use 4-bank addressing through one CPU and 8-bank addressing through the remaining CPUs in the partition.

Configuration Parameters

SCE enables you to modify individual parameters for the memory, CPU, shared, I/O, and channel configurations. Use the  menu button to access the parameters. For more information about the commands available from the  menu button, refer to the *SCE Interface Reference*, publication number HDM-182-B.

CAUTION

Do not change individual parameters in the SCE popup windows unless you use caution and have a thorough understanding of CRAY T90 series mainframe configuration.

Partitioning

SCE controls all partitioning of the mainframe. Partitioning the mainframe enables multiple customer functions or maintenance functions to occur in different areas of the mainframe at the same time. This enables one portion of the mainframe to run customer operations while you maintain or repair another portion; it also enables a customer to run more than one operating system (OS) at a time.

NOTE: At the time of this printing, UNICOS does not support partitioning.

Physical Partitions

You can configure CRAY T90 series mainframes into one or two physical partitions, depending on the mainframe type. CRAY T94 and CRAY T916 mainframes have one physical partition, and CRAY T932 mainframes can have one or two physical partitions. A CRAY T932 mainframe configured with two physical partitions can function as two separate mainframes.

Each physical partition has an associated sanity tree, which establishes connections between modules. CRAY T94 and CRAY T916 mainframes have one sanity tree. CRAY T932 mainframes have one or two sanity trees, depending on the number of IO modules in the mainframe and the number of physical partitions that you create in the mainframe.

Logical Partitions

Physical partitions are divided into sets of components called logical partitions. Each physical partition contains one to four logical partitions. This enables you to create up to four logical partitions for CRAY T94 and CRAY T916 mainframes and up to eight logical partitions for CRAY T932 mainframes. Physical partitions are divided into logical partitions through changes to the soft switch values.

How SCE Creates Logical Partitions

SCE creates logical partitions by assigning components of the mainframe into the same memory group, I/O group, and cluster group, as shown in Table 1. These groups determine how the modules can interact.

Table 1. Logical Partition Group Assignment

Logical Partition	Memory Group	I/O Group	Cluster Group
0	0	0	0
1	1	1	1
2	2	2	2
3	3	3	3

A memory group is a logical grouping of a portion of memory and CPUs. A CPU can access only the memory that is in the same memory group as the CPU.

An I/O group is a logical grouping of CPUs, LOSP channels, and VHISP channels. A CPU can access only the channels that are in the same I/O group as the CPU.

A cluster group is a logical grouping of shared register clusters and CPUs. A CPU can use only the clusters that are in the same cluster group as the CPU.

SCE ensures that components are placed in the proper groups as you use the base window to define your logical partitions. You can also change the group parameters by using the SCE subwindows (available through the **View** menu button), but this is not recommended. Do not modify the subwindow parameters unless you use caution and have a thorough understanding of CRAY T90 series mainframe configuration.

Logical Partition Ownership

Logical partition ownership determines the type of customer or maintenance operations allowed in the logical partitions. Logical partitions that have an operating system (OS) owner are used by a customer operating system. Logical partitions with a maintenance system (MS) owner are used by the maintenance system.

An OS owner does not imply any particular operating system. OS-owned logical partitions have two attributes: online maintenance allowed (OMA) and concurrent maintenance allowed (CMA). Online maintenance is maintenance under control of the operating system. Concurrent maintenance is an offline environment in a restricted subset of the logical partition's components.

All components of the mainframe (CPUs, clusters, I/O channels, etc.) are either assigned or unassigned to a logical partition. Components that are assigned to a logical partition with an OS owner are not available for maintenance use. Components that are assigned to a logical partition with an MS owner are not available for customer use. Components that are currently unassigned are available for customer or maintenance use; these components must be assigned to a logical partition before they can be used.

Components are classified by three states: working, broken, or unavailable. *Working* indicates that a component is in working condition. *Broken* indicates that a component is not in working condition. *Unavailable* indicates that a component is not logically present in the mainframe. Unavailable CP, SR, and IO modules are not part of the sanity tree. Unavailable memory modules are handled with memory degrade options.

Creating Physical Partitions and Logical Partitions

The easiest way to create physical partitions and logical partitions is to use the settings available in the base window (refer to Figure 1). Click on the settings you want, and SCE generates a sequence of maintenance channel functions that is sent to the mainframe when the configuration is applied. This sequence builds the appropriate physical partitions and logical partitions.

The screenshot shows the 'System Configuration Environment (SCET90 1.2.0) - SIM [techsun] (76)' window. It is divided into three main sections:

- System Information Parameters:** Includes System Type (T94), System Serial (7001), System Memory (512K), and Physical Partitions (1, 2).
- Physical Partition Parameters †:** Includes Current Physical Partition (0), Sanity Port (I/O A), Sparechips (Disabled/Enabled), and Logical Partitions (1, 2, 3, 4).
- Logical Partition Parameters:** Includes Current Logical Partition (0), Memory (512K), Owner (OS, Maintenance, In Use), Maintenance (On-Line Enabled, Concurrent Enabled), and Description (PPO, LPO). Below this are tables for CPUs, LOSPs, HISPs, and VHISPs.

At the bottom, a message states: 'New configuration - apply/assert required.'

† Additional physical partition parameters are now located in the SCE T90: Miscellaneous window, which is shown in Figure 13 on page 31. Choose **View → Miscellaneous** to access the parameters for the maintenance channel, boundary scan channel, error logger channel, and support channel.

Figure 1. Physical and Logical Partition Parameters in the Base Window

Memory Degradation

SCE can also degrade memory, which enables you to continue system operation or perform system maintenance in the presence of memory system failures. You may degrade a system until a CPU addresses only one bank of memory in each of four memory sections (a total of two memory modules with only one-eighth of the memory on each of those modules in use).

When you degrade memory, you are bypassing areas in memory where failures occur; then, the system can continue to operate and you may perform system maintenance on the degraded portion of memory. By degrading memory, you are forcing selected section, subsection, and bank bits to a specific value. Therefore, the memory address referenced by the CPU is different than the address received by memory.

Use the memory configuration parameters to degrade memory used in a mainframe. For more information about the memory configuration parameters, refer to the “View → Memory” description in the *SCE Interface Reference*, publication number HDM-182-B.

NOTE: All configuration selections apply symmetrically within the CPUs in the selected partition; for example, selecting 4-bank mode within a CPU means that all requests on all memory ports use 4-bank addressing. It is not possible to use 4-bank addressing through one CPU and 8-bank addressing through the remaining CPUs in the partition.

What SCE Does to Degrade Memory

SCE degrades memory by configuring the CP modules to force certain address bits to a 0 or 1 and to shift the remaining bits 1 bit higher. This process causes the CP modules to avoid addressing (and using) the degraded memory. To do this, SCE manipulates the section, subsection, and bank profile and select bits.

The section profile bit indicates whether or not a bit should be added to the section portion of the address bits. If the section profile bit is set to 1, SCE configures the CP modules to add a bit to the section portion of the address bits and shift the higher bits one position to the left. The section select bit sets the extra bit to 0 or 1.

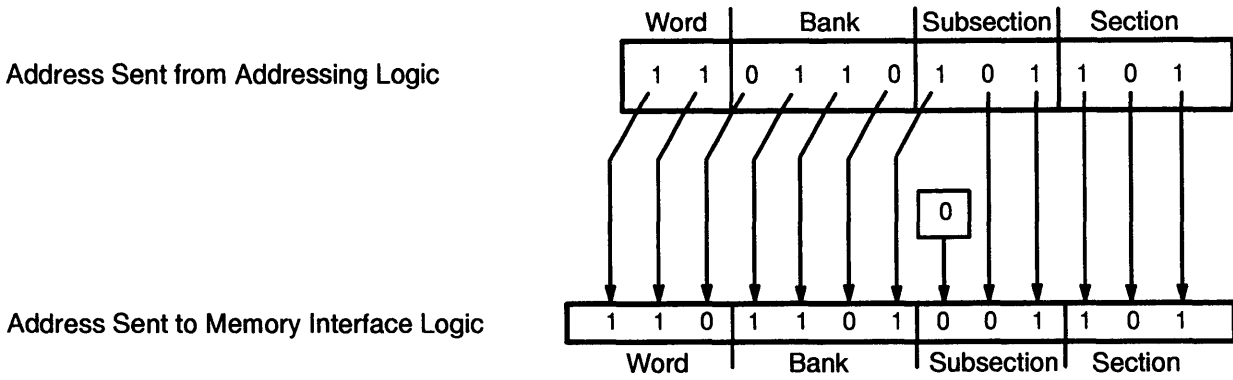


Figure 3. Forcing Address Bit 5 to a 0

Figure 4 shows an example of memory degradation by banks, subsections, and sections. The CP modules avoid addressing banks 10, 11, 12, 13, 14, 15, 16, and 17; subsections 4, 5, 6, and 7; and sections 0, 1, 2, and 3.

In this example, SCE configures the CP modules to force address bit 9 to a 0, address bit 5 to a 0, and address bit 2 to a 1. SCE configures the CP modules to shift the corresponding higher bits one position to the left. (To do this, SCE sets the bank 2^3 profile bit to 1 and the bank 2^3 select bit to 0, the subsection 2^2 profile bit to 1 and the subsection 2^2 select bit to 0, and the section 2^2 profile bit to 1 and the section 2^2 select bit to 1.)

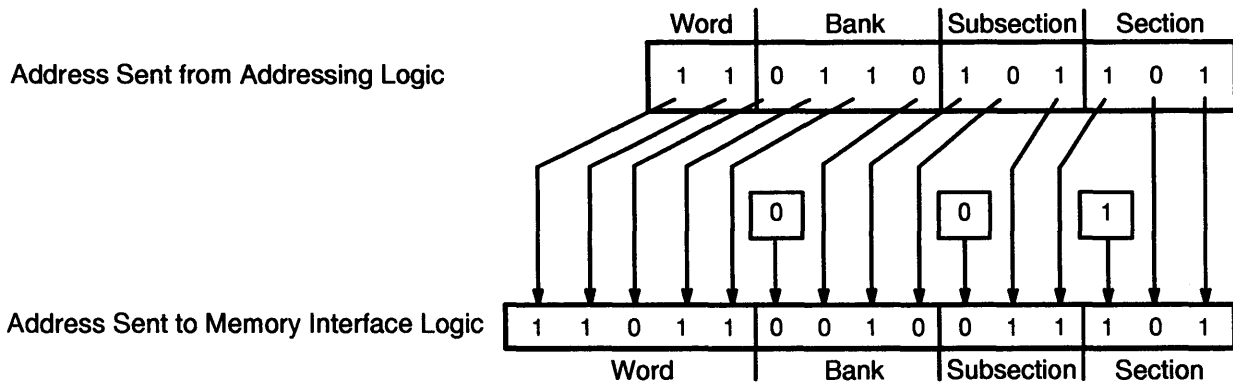


Figure 4. Forcing Address Bit 9 to a 0, Address Bit 5 to a 0, and Address Bit 2 to a 1

Each time an address bit is forced to a 0 or 1, the amount of memory available for use is reduced by one-half.

Using SCE to Degrade Memory

Choose **View → Memory** to access the SCET90 Memory window to perform memory degradation. This window provides two modes that you can use to perform memory degradation: default mode and custom mode.

In default mode, you simply specify which sections, subsections, and banks of memory you want to use. SCE forces the necessary address bits to degrade the memory that you do not want to use.

In custom mode, you can perform memory degradations for individual sections. For example, you could degrade 1 section to use 4 banks (for example, banks 0, 1, 2, and 3) while the other sections use the other 4 banks (banks 4, 5, 6, and 7).

Refer to the *SCE Interface Reference*, publication number HDM-182-B, for more information about the SCET90 Memory window and the parameters that are available in default and custom modes. Refer to “Degrading Memory in a CRAY T932 Mainframe (with CM03 Modules)” on page 40 and “Degrading Memory in a CRAY T916 Mainframe (with CM02 Modules)” on page 46 for examples of using SCE to perform memory degradation.

Preferred Sequence for Memory Degradations

NOTE: If only one memory chip fails in a half-bank, you do not need to perform a memory degradation. Instead, you can simply reconfigure a spare chip to replace the flawed chip. Using a spare chip is not a form of memory degradation, and it will not cause more conflicts. (Refer to “Spare Chip Memory Management” on page 17 of this document for more information.)

If more than one chip fails in a half-bank, you can degrade memory by banks or sections (for a CRAY T94 system) or by banks, subsections, or sections (for CRAY T916 and CRAY T932 systems).

For a given memory fault, there may be more than one way to degrade memory so that the mainframe can continue to operate. All degradations cause more conflicts for the remaining memory, so the preferred degradation (degrade) is the one that minimizes the number of conflicts. Memory degradations that occur farther away from CPUs cause fewer memory conflicts. This means that if no other reasons exist to start degrades elsewhere, you should degrade by banks, then by subsections (for CRAY T916 and CRAY T932 systems), and then by sections.

If a bank fails, degrade by banks, if possible. If a module fails, degrade by subsections, if possible. When you degrade by banks, degrade by the upper bank bit first, followed by the lower bank bit. When you degrade by subsections (CRAY T916 and CRAY T932 systems only), degrade in bit order, starting with the lowest bit.

Special Conditions for Memory Degradation with CP Testers and CRAY T916 Mainframes

There are special memory configuration conditions for CP testers and CRAY T916 mainframes that you should understand before you perform memory degradation for these systems. To configure these systems, SCE maps the sections to specific banks so it appears that there are 8 sections and 8 banks (for systems with CM02 modules) or 8 sections and 16 banks (for systems with CM03 modules).

NOTE: The section-to-bank mappings shown in the following paragraphs are the preferred configurations for CP testers and CRAY T916 mainframes because these mappings provide the best performance. You can use other mappings if you follow the patterns that are shown in the following paragraphs. (For example, the pattern for CRAY T916 mainframes with CM02 memory modules is that you must map sections 0, 1, 4, and 5 to the same 4 banks and sections 2, 3, 6, and 7 to the same 4 banks.)

Section-to-bank Mapping for CP Testers

For CP testers with CM02 memory modules, SCE uses the following section-to-bank mapping (refer to Figure 5):

- Section 0 goes to banks 0 and 4
- Section 1 goes to banks 0 and 4
- Section 2 goes to banks 1 and 5
- Section 3 goes to banks 1 and 5
- Section 4 goes to banks 2 and 6
- Section 5 goes to banks 2 and 6
- Section 6 goes to banks 3 and 7
- Section 7 goes to banks 3 and 7

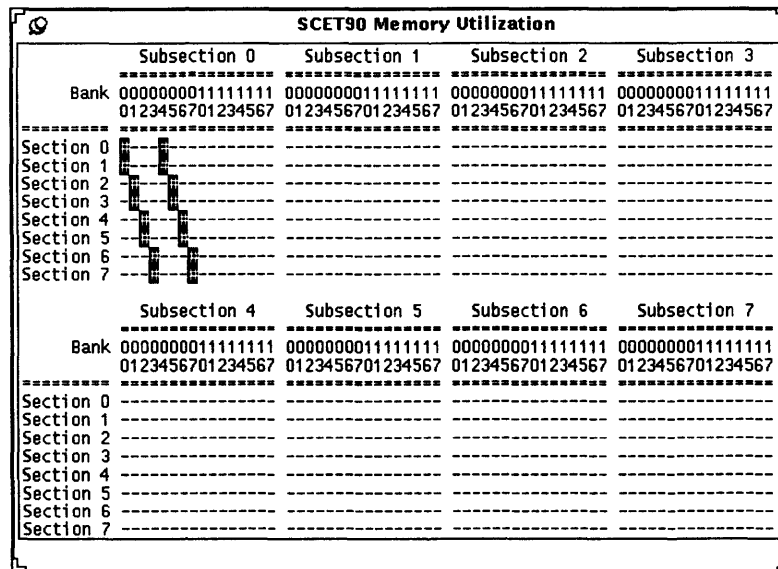


Figure 5. Memory Utilization Map for a CP Tester with a CM02 Module

For CP testers with CM03 memory modules, SCE uses the following section-to-bank mapping (refer to Figure 6):

- Section 0 goes to banks 0, 4, 10, and 14
- Section 1 goes to banks 0, 4, 10, and 14
- Section 2 goes to banks 1, 5, 11, and 15
- Section 3 goes to banks 1, 5, 11, and 15
- Section 4 goes to banks 2, 6, 12, and 16
- Section 5 goes to banks 2, 6, 12, and 16
- Section 6 goes to banks 3, 7, 13, and 17
- Section 7 goes to banks 3, 7, 13, and 17

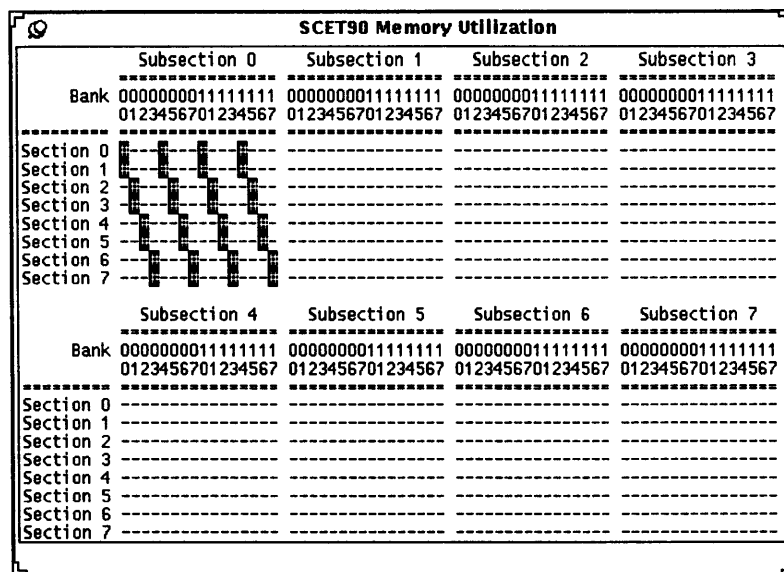


Figure 6. Memory Utilization Map for a CP Tester with a CM03 Module

Section-to-bank Mapping for CRAY T916 Mainframes

For CRAY T916 mainframes with CM02 memory modules, SCE uses the following section-to-bank mapping (refer to Figure 7):

- Section 0 goes to banks 0, 1, 4, and 5
- Section 1 goes to banks 0, 1, 4, and 5
- Section 2 goes to banks 2, 3, 6, and 7
- Section 3 goes to banks 2, 3, 6, and 7
- Section 4 goes to banks 0, 1, 4, and 5
- Section 5 goes to banks 0, 1, 4, and 5
- Section 6 goes to banks 2, 3, 6, and 7
- Section 7 goes to banks 2, 3, 6, and 7

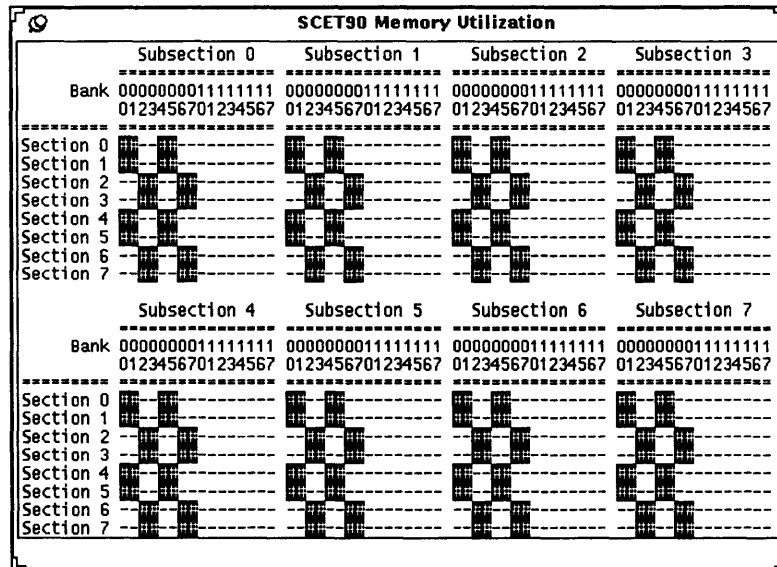


Figure 7. Memory Utilization Map for a CRAY T916 Mainframe with CM02 Modules

For CRAY T916 mainframes with CM03 memory modules, SCE uses the following section-to-bank mapping (refer to Figure 8):

- Section 0 goes to banks 0, 1, 4, 5, 10, 11, 14, and 15
- Section 1 goes to banks 0, 1, 4, 5, 10, 11, 14, and 15
- Section 2 goes to banks 2, 3, 6, 7, 12, 13, 16, and 17
- Section 3 goes to banks 2, 3, 6, 7, 12, 13, 16, and 17
- Section 4 goes to banks 0, 1, 4, 5, 10, 11, 14, and 15
- Section 5 goes to banks 0, 1, 4, 5, 10, 11, 14, and 15
- Section 6 goes to banks 2, 3, 6, 7, 12, 13, 16, and 17
- Section 7 goes to banks 2, 3, 6, 7, 12, 13, 16, and 17

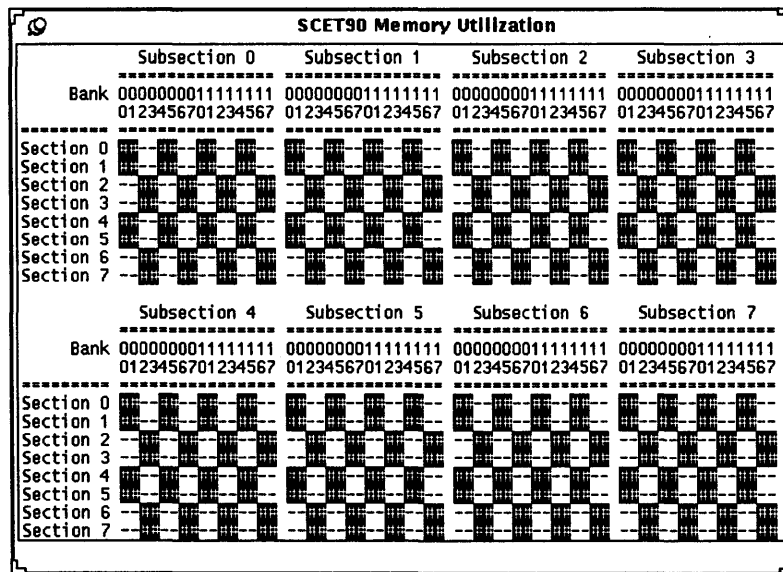


Figure 8. Memory Utilization Map for a CRAY T916 Mainframe with CM03 Modules

How These Special Conditions Affect Memory Degradation

When you want to perform memory degradation by banks for a CP tester or a CRAY T916 mainframe, you should use custom mode because you will need to change the section-to-bank mappings for the memory that you want to degrade. Custom mode displays how the sections are configured to specific banks. For example, Figure 9 shows the section-to-bank mappings for a CRAY T916 mainframe with CM02 memory modules.

Banks: <input type="checkbox"/>						
		2^3	2^2	2^1	2^0	
Section 0:	<input type="checkbox"/>	0	-	0	-	0,1,4,5
Section 1:	<input type="checkbox"/>	0	-	0	-	0,1,4,5
Section 2:	<input type="checkbox"/>	0	-	1	-	2,3,6,7
Section 3:	<input type="checkbox"/>	0	-	1	-	2,3,6,7
Section 4:	<input type="checkbox"/>	0	-	0	-	0,1,4,5
Section 5:	<input type="checkbox"/>	0	-	0	-	0,1,4,5
Section 6:	<input type="checkbox"/>	0	-	1	-	2,3,6,7
Section 7:	<input type="checkbox"/>	0	-	1	-	2,3,6,7

Figure 9. Bank Parameters in Custom Mode

For CP testers with CM02 modules, bank configuration in custom mode is as follows:

16 of 16 banks	(not valid)
8 of 16 banks	(not valid)
4 of 16 banks	(not valid)
2 of 16 banks	(all banks)
1 of 16 banks	(degraded to use half of the banks)

For CP testers with CM03 modules, bank configuration in custom mode is as follows:

16 of 16 banks	(not valid)
8 of 16 banks	(not valid)
4 of 16 banks	(all banks)
2 of 16 banks	(degraded to use half of the banks)
1 of 16 banks	(degraded to use a quarter of the banks)

For CRAY T916 systems with CM02 modules, bank configuration in custom mode is as follows:

16 of 16 banks	(not valid)
8 of 16 banks	(not valid)
4 of 16 banks	(all banks)
2 of 16 banks	(degraded to use half of the banks)
1 of 16 banks	(degraded to use a quarter of the banks)

For CRAY T916 systems with CM03 modules, bank configuration in custom mode is as follows:

16 of 16 banks	(not valid)
8 of 16 banks	(all banks)
4 of 16 banks	(degraded to use half of the banks)
2 of 16 banks	(degraded to use a quarter of the banks)
1 of 16 banks	(degraded to use an eighth of the banks)

Refer to “Degrading Memory in a CRAY T916 Mainframe (with CM02 Modules)” on page 46 to see an example of degrading memory by banks in a CRAY T916 mainframe.

Spare Chip Memory Management

As described in the *Memory Module (CM02)* document, publication number HTM-004-0, you can flaw failing memory chips. You can then have SCE configure the mainframe to use spare memory chips that are physically located in the same row of chips in the memory stack as the flawed chips.

Use the SCE T90: Spare Chip window to create and maintain a table of modules with flawed chips. SCE uses this table to generate the appropriate direct memory access (DMA) commands to replace the flawed chips with spare chips.

To flaw a chip, you need the following information: bank, subsection, section, and bad bit. This information can come from the error logging program (`xelog`), the MME error log, or a diagnostic test program.

NOTE: When you are using spare memory chips, you should set the Debug Level setting to `Internals`. This causes SCE to display the flaw map in the standard output window when you assert a configuration. By viewing the flaw map during an assertion, you will see any errors related to the spare chip assignment. For example, if you enter 2 flaws in the same stack (which invalidates the first flaw), SCE will not display an error until you assert the configuration.

How SCE Controls the Spare Chips

SCE uses two hidden files in the `usr/cfg` directory to implement spare-chip functionality. The `.mmm` file contains a memory module map that defines which modules are in the system. The `.scm` file contains a spare-chip map that describes which chips are flawed (the information that you provide to SCE). The `.mmm` and `.scm` files are in a binary format; you cannot manually edit these files.

SCE uses the memory module map, spare-chip map, and memory degradation information to build flaw maps. When you apply a configuration, SCE generates the flaw maps and writes each logical partition with a flaw map. All spare-chip memory management activity is transparent to the OS.

Guidelines for Using Spare Chips

Use the following guidelines to determine whether you should use SCE's spare-chip management function to flaw a chip so that a spare chip replaces the flawed chip.

Single-byte Errors

A single-byte error (SBE) means that 1 to 2 bits are failing on the same memory chip.

During a 24-hour period, a memory chip that exhibits a consistent or increasing failure rate is a possible candidate for flawing. Monitor the frequency of failures over a 7-day period; at least 250 hits per day over a 7-day period should occur before you consider flawing the chip. However, use the spare chip feature before system performance is compromised.

NOTE: You should log all SBEs as they occur for individual modules. If a module is returned to Central Repair for a double-bit error or meets the criteria to be returned for flaws, this log and the flaw map should accompany the module. The log enables Central Repair to change chips that do not currently meet the criteria for flawing but that may fail more seriously in the future.

Bursting Memory Chips

A burst is made up of multiple SBEs logged rapidly in a short time. Bursts are not counted in specific numbers; for example, *more than 500* hits in 1 second would be considered a burst.

During a 24-hour period, a memory chip that experiences one burst is not a candidate for flawing. If the chip experiences more than three bursts during a 24-hour period, it is a possible candidate for flawing.

During a 7-day period, a memory chip that experiences one burst is not a candidate for flawing. If the burst repeats on more than 3 days during a 7-day period, you may consider flawing the chip.

Using Spare Memory Chips

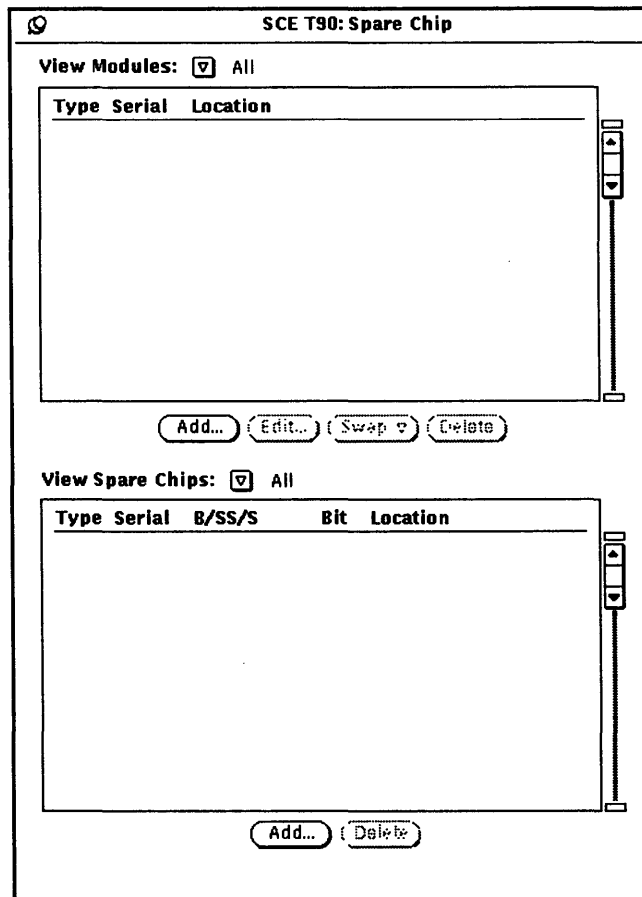
SCE includes the following functions to enable you to flaw a failing chip to use the spare memory chips:

- Creating a new flaw-chip entry
- Swapping module entries
- Editing a module entry
- Deleting a module entry
- Deleting a flaw-chip entry
- Viewing all module entries
- Viewing specific module entries
- Viewing all flaw-chip entries
- Viewing specific flaw-chip entries

Creating a New Flaw-chip Entry

Perform the following procedure to create a new flaw-chip entry in the table.

1. Choose **View → Spare Chip** in the SCE base window. The SCE T90: Spare Chip window appears:



Before you can enter the bank, subsection, section, and bad bit information; you must create an entry for the memory module.

- In the SCE T90: Spare Chip window, click on **Add...** (located below the View Modules scroll box) to add a module entry to the table. SCE displays the SCE T90: Module Add window:

- In the Module Serial field, enter the serial number of the module.
- Click on Module Type: **CM02** or **CM03** to indicate the memory module type.
- Specify the location of the module:
 - If the module is a spare module that is not installed in the mainframe, click on Module Location: **Spare**.
 - If the module is installed in the mainframe, click on Module Location: **Mainframe**. Then, specify the Mainframe Type you are using (click on **Tester**, **T94**, **T916**, or **T932**). Then, enter the serial number of the mainframe in the Mainframe Serial field, and click on the Mainframe Slot in which the memory module is located.
- Click on **Apply** in the SCE T90: Module Add window to insert the module information into the table.

Once you have created a module entry, you can add flawed-chip information to the table.

- In the SCE T90: Spare Chip window, click on (located below the View Spare Chips scroll box) to add a flaw-chip entry to the table. SCE displays the SCE T90: Spare Chip Add window:

SCET90: Spare Chip Add

Location:

Bank:

0	1	2	3	4	5	6	7
10	11	12	13	14	15	16	17

Subsection:

0	1	2	3	4	5	6	7
---	---	---	---	---	---	---	---

Section:

0	1	2	3	4	5	6	7
---	---	---	---	---	---	---	---

Bad Bit:

0	1	2	3	4	5	6	7	8	9
10	11	12	13	14	15	16	17	18	19
20	21	22	23	24	25	26	27	28	29
30	31	32	33	34	35	36	37	38	39
40	41	42	43	44	45	46	47	48	49
50	51	52	53	54	55	56	57	58	59
60	61	62	63	64	65	66	67	68	69
70	71	72	73	74	75				

- From the Location: , choose the serial number for the mainframe or the spare module on which the flawed chip is located.
- Click on the appropriate Bank, Subsection, Section, and Bad Bit settings.

NOTE: The subsection parameter does not apply to CRAY T94 mainframes because they do not have subsections.

- Click on in the SCE T90: Spare Chip Add window to insert the flawed-chip information into the table.

SCE substitutes a spare chip for the flawed chip the next time you apply the configuration if the spare-chip option is enabled for the physical partition that contains the flawed chip.

Swapping Module Entries

SCE enables you to swap two module entries, which represents swapping the physical modules. To swap module entries, select one module you want to swap. Then, choose the module with which you want to swap from the **Swap ▾** menu button.

Editing a Module Entry

Click on **Edit..** to edit a module entry. SCE displays a Module Edit window that displays the current values for the module entry. Change the values and click on **Apply** in the Module Edit window.

Deleting a Module Entry

To delete a module entry, select the entry in the View Modules scroll box and click on **Delete** (located below the View Modules scroll box).

Deleting a Flaw-chip Entry

To delete a flaw-chip entry, select the entry in the View Spare Chips scroll box and click on **Delete** (located below the View Spare Chips scroll box).

Viewing All Module Entries

SCE displays all module entries in the View Modules scroll box when you choose All from the View Modules: **▾**.

Viewing Specific Module Entries

SCE displays only module entries for a specific mainframe in the View Modules scroll box when you choose the mainframe serial number from the View Modules: **▾**.

SCE displays only module entries for spare modules in the View Modules scroll box when you choose Spare from the View Modules: **▾**.

Viewing All Flaw-chip Entries

SCE displays all current flaw-chip entries in the View Spare Chips scroll box when you choose All from the View Spare Chips: **▾**.

Viewing Specific Flaw-chip Entries

SCE displays only the flaw-chip entries for a specific module in the View Spare Chips scroll box when you choose the module from the View Spare Chips:

Special Conditions for Using Spare Chips with CP Testers and CRAY T916 Mainframes

There are special memory configuration conditions that occur for CP testers and CRAY T916 mainframes that you should remember when you use spare chips with these systems.

A CP tester has only one memory module, but the memory configuration appears to be 8 sections and 8 banks. When you enter spare-chip information for a tester, SCE maps the section information to an odd or even value.

A CRAY T916 mainframe has 16 memory modules, but the memory configuration appears to have 8 sections, 8 subsections, and 4 banks. [Sections 2, 3, 4, and 5 are on the same module (stack). Sections 2 and 3 go to 4 of the 8 banks, and sections 4 and 5 are mapped to the other 4 banks.] When you enter spare-chip information for a CRAY T916 mainframe, SCE restricts the section values to 0, 1, 2, or 3. Section 4 maps to section 2; section 5 maps to section 3, section 6 maps to section 0; and section 7 maps to section 1. SCE displays the original and mapped sections in the spare-chip list.

USING SCE

The following procedure provides a general overview of the process for using SCE. This section includes related information for each step of the process.

1. Starting SCE
2. Creating a configuration
3. Asserting the configuration
4. Modifying the configuration
5. Asserting the modified configuration
6. Repeating Step 4 and Step 5 (as needed to adjust the configuration)

Starting SCE

You can start SCE from a UNIX prompt or from the OpenWindows Workspace menu.

NOTE: For information about starting SCE from a Service Center through a hub, refer to the *Remote Support* document, publication number HMM-106-0.

From a UNIX Prompt

You can start SCE from a UNIX prompt with the following command:

```
sce [-copy num] [-default filename] [-kill]
    [-remote host | -client | -server]
    [-sim]
```

Table 2 describes the available command line options.

Table 2. Command Line Options

Option	Description
-client	Start SCE client only
-copy <i>num</i>	Connect to maintenance software assigned the copy number specified by <i>num</i> NOTE: Copy numbers are necessary only when you run multiple copies of SCE on the same MWS (for example, when you run several SCE copies with the simulator or when you use SCE to support multiple CRAY T90 series mainframes connected to the same MWS).
-default <i>filename</i>	Load configuration file <i>filename</i> and apply the configuration
-kill	Kill all maintenance system processes (MME, LME, SCE) before starting SCE
-remote <i>host</i>	Start SCE client only and connect to server on <i>host</i>
-server	Start SCE server only
-sim	Start SCE with the simulator

From the OpenWindows Workspace Menu

Figure 10 shows the OpenWindows Workspace menu options you should choose to start SCE with an FEI channel. Choose any copy number.

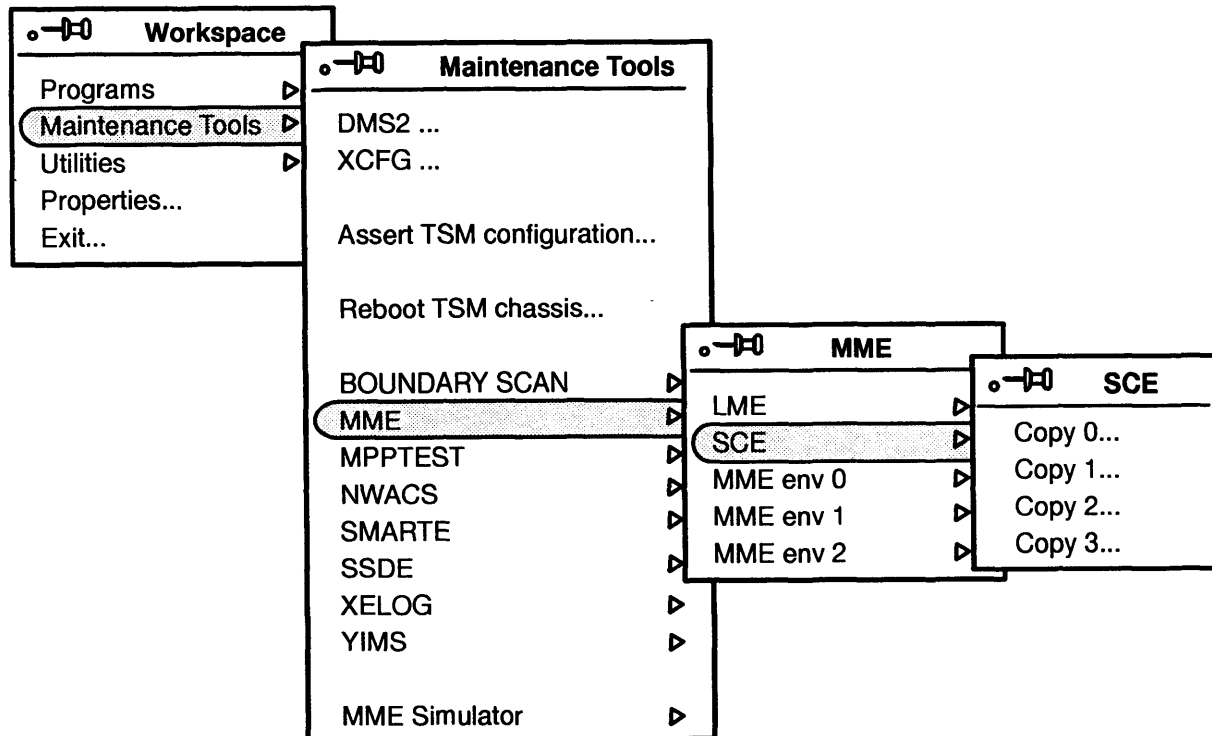


Figure 10. Workspace Menu Options to Start SCE with an FEI Channel

Figure 11 shows the OpenWindows Workspace menu options you should choose to start SCE with the simulator.

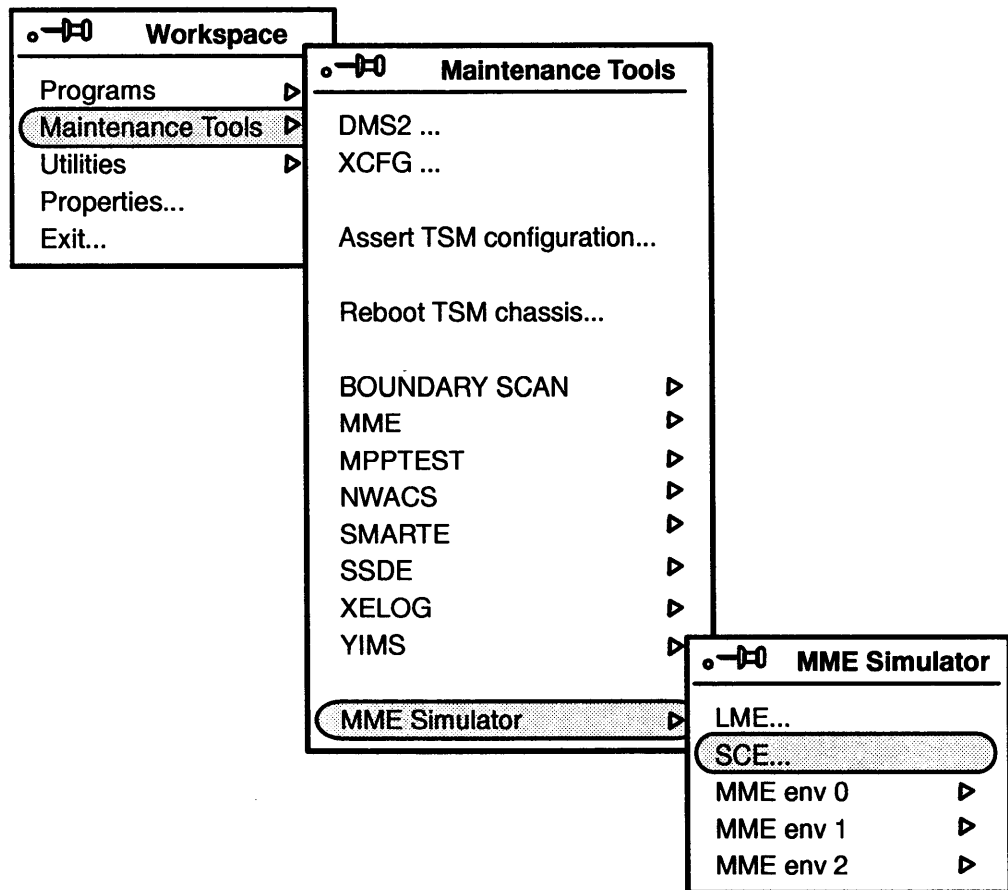


Figure 11. Workspace Menu Options to Start SCE with the Simulator

Creating a Configuration

When you first start SCE, you need to set the parameters for the initial mainframe configuration. There are two ways to create the configuration: you can load a previously saved configuration or create a new configuration.

Loading an Existing Configuration

Use the File → Load command to load an existing configuration file.

Creating a New Configuration

You normally use only the SCE base window to create a new configuration because the base window contains all the parameters necessary to create most typical configurations. The following procedure describes how to use the SCE base window to create a new configuration.

1. Choose **File → New → T94** to create a new CRAY T94 mainframe configuration, choose **File → New → T916** to create a new CRAY T916 mainframe configuration, or choose **File → New → T932** to create a new CRAY T932 configuration.

SCE loads a set of default values, which appear in the SCE base window. Figure 12 on page 30 shows the SCE base window with default values for a CRAY T94 mainframe configuration.

2. Modify the system information parameters to indicate the serial number, amount of system memory, and number of physical partitions.
3. Set up the configuration information for the current physical partition.
4. Modify the logical partition parameters to create each logical partition.

For each logical partition, you will specify the owner of the partition (operating system or maintenance), the CPUs in the partition, the cluster information for the partition, the LOISP channels in the partition, the HISPC channels in the partition, and the VHISPC channels in the partition.

5. Use the **File** → **Save** command to save the configuration. This enables you to reload the configuration later with the **File** → **Load** command.

The screenshot shows the SCE Base Window with the following configuration details:

- System Information Parameters:** System Type: T94, System Serial: 7001, System Memory: 512K, Physical Partitions: 1 2.
- Physical Partition Parameters †:** Current Physical Partition: 0, Sanity Port: I/O A, Sparechips: Disabled Enabled, Logical Partitions: 1 2 3 4.
- Logical Partition Parameters:** Current Logical Partition: 0, Memory: 512K, Owner: OS Maintenance In Use, Maintenance: On-Line Enabled Concurrent Enabled, Description: PPO, LPO.
- CPUs:** A 4x4 grid of CPU IDs from 00 to 37.
- Cluster Settings:** Cluster Offset: 1, Cluster Range: 22, Auto BCD: Off On.
- Memory Mappings:**
 - LOSps:** A grid of memory addresses from 100/101 to 060/061.
 - HISPs:** A grid of memory addresses from 400/410 to 407/417.
 - VHISPs:** A grid of memory addresses from 020/030 to 027/037.

New configuration – apply/assert required.

† Additional physical partition parameters are now located in the SCE T90: Miscellaneous Configuration window, which is shown in Figure 13. Choose **View** → **Miscellaneous** to access the parameters for the maintenance channel, boundary scan channel, error logger channel, and support channel.

Figure 12. Default Parameter Locations in the SCE Base Window

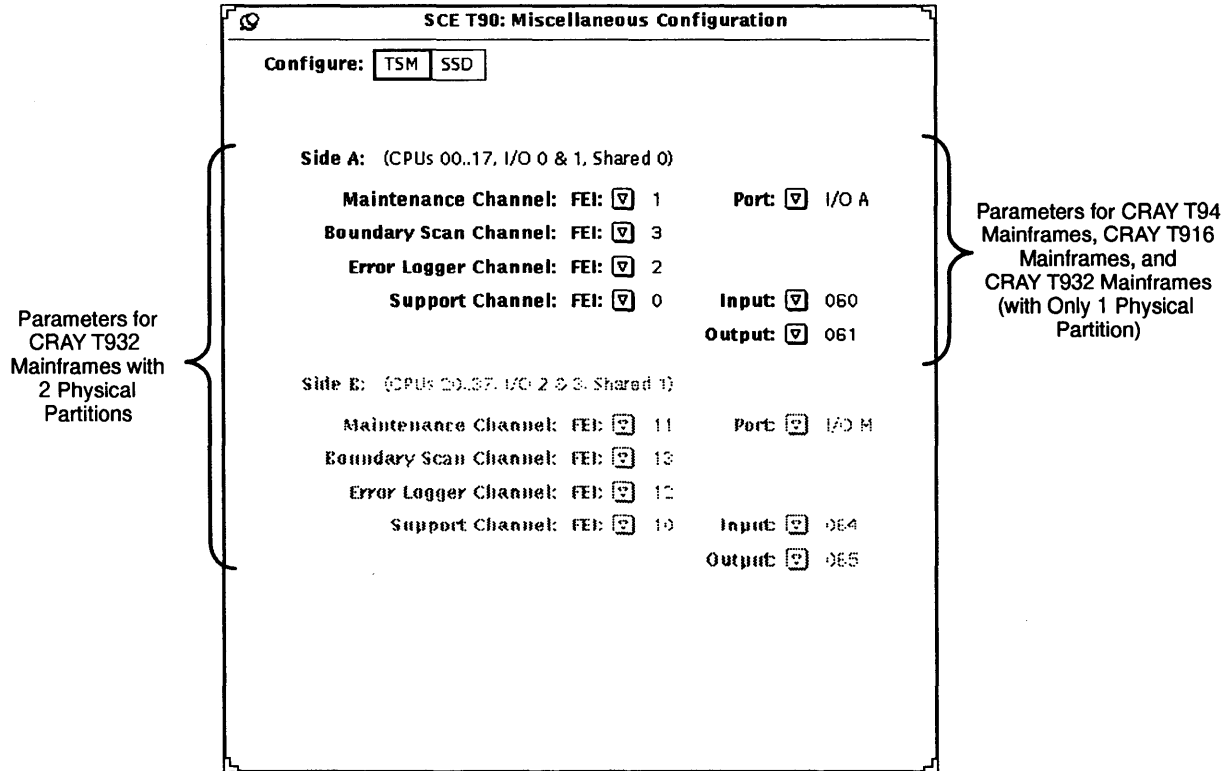


Figure 13. Default Parameter Locations in the SCE T90: Miscellaneous Configuration Window

Asserting the Configuration

Once you have set the parameters for the initial configuration, you need to assert the configuration to configure the CRAY T90 series mainframe. Asserting the configuration builds the sanity tree(s) for your specified configuration.

CAUTION


Asserting a configuration halts all operating system and user activity in the mainframe. Data is lost if an operating system is running in the mainframe when you assert a configuration.

Choose **Assert → Physical Partition 0**, **Assert → Physical Partition 1**, or **Assert → Both Partitions** to assert the configuration. SCE asserts the configuration.

NOTE: There are two other options for updating a configuration: you can apply the configuration or assume the configuration. Applying the configuration causes SCE to attempt to reconfigure the mainframe without rebuilding the sanity tree(s). Assuming the configuration sends the configuration data to SCE's clients without updating the sanity tree.


For descriptions of the actions that SCE performs to assert, apply, or assume a configuration, refer to the "Assert -> Physical Partition 0," "Assert -> Physical Partition 1," "Assert -> Both Partitions," "Apply -> Physical Partition 0," "Apply -> Physical Partition 1," "Apply -> Both Partitions," "Assume -> Physical Partition 0," "Assume -> Physical Partition 1," and "Assume -> Both Partitions" descriptions in the *SCE Interface Reference*, publication number HDM-182-B.

Modifying the Configuration

You may need to modify the configuration to degrade memory, to modify the available partitions to perform maintenance, or to use the spare memory chips. You can modify the configuration by changing parameters in the SCE base window or by changing the parameters in the windows that you can access with the  menu button commands.

CAUTION

Do not change individual parameters in the SCE popup windows unless you use caution and have a thorough understanding of CRAY T90 series mainframe configuration.

For more information about the commands available from the  menu button, refer to the *SCE Interface Reference*, publication number HDM-182-B.

Asserting the Modified Configuration

CAUTION

Asserting a configuration halts all operating system and user activity in the mainframe. Data is lost if an operating system is running in the mainframe when you assert a configuration.

Choose **Assert → Physical Partition 0**, **Assert → Physical Partition 1**, or **Assert → Both Partitions** to assert the configuration. SCE asserts the modified configuration. Asserting the configuration rebuilds the sanity tree(s) for your modified configuration.

NOTE: There are two other options for updating a configuration: you can apply the configuration or assume the configuration. Applying the configuration causes SCE to attempt to reconfigure the mainframe without rebuilding the sanity tree(s). Assuming the configuration sends the configuration data to SCE's clients without updating the sanity tree.

For descriptions of the actions that SCE performs to assert, apply, or assume a configuration, refer to the "Assert → Physical Partition 0," "Assert → Physical Partition 1," "Assert → Both Partitions," "Apply → Physical Partition 0," "Apply → Physical Partition 1," "Apply → Both Partitions," "Assume → Physical Partition 0," "Assume → Physical Partition 1," and "Assume → Both Partitions" descriptions in the *SCE Interface Reference*, publication number HDM-182-B.

SCE EXAMPLES

This section provides the following examples to illustrate the functions you can perform with SCE:

- Creating a new CRAY T94 configuration
- Degrading memory in a CRAY T932 mainframe
- Degrading memory in a CRAY T916 mainframe
- Setting up a partition for maintenance
- Flawing a bad memory chip

Creating a New CRAY T94 Configuration

This example shows how to create a configuration for a CRAY T94 mainframe. This example configuration includes all possible modules and channels. The configuration includes 1 physical partition, 1 logical partition, and 128 Mwords of memory. The mainframe serial number is 7001.

1. Choose **File** → **New** → **T94** to create a new CRAY T94 mainframe configuration. SCE creates a default set of parameters.
2. Modify the system information parameters to indicate the serial number, amount of system memory, and number of physical partitions.

Table 3 shows the system information parameter settings necessary to configure the CRAY T94 mainframe for this example.

Table 3. Example System Information Parameter Settings

Parameter	Setting
System Type	T94
System Serial	7001
System Memory	128M
Physical Partitions	1 (for CRAY T94 mainframe)

3. Set up the configuration information for the current physical partition.

Table 4 shows the physical partition parameter settings for this example.

Table 4. Example Physical Partition Parameter Settings

Parameter	Setting
Current Physical Partition †	0 (CRAY T94 mainframes have only one physical partition)
Sanity Port †	<i>Left at the default for this example</i>
Sparechips †	<i>Left at the default for this example</i>
Logical Partitions †	1
Maintenance Channel ‡	<i>Left at the default for this example</i>
Boundary Scan Channel ‡	<i>Left at the default for this example</i>
Error Logger Channel ‡	<i>Left at the default for this example</i>
Support Channel ‡	<i>Left at the default for this example</i>
Input ‡	<i>Left at the default for this example</i>
Output ‡	<i>Left at the default for this example</i>

† These parameters are located in the SCE base window.

‡ These parameters are located in the SCE T90: Miscellaneous Configuration window. Choose **View** → **Miscellaneous** to access this window.

4. Modify the logical partition parameters to create each logical partition.

Table 5 shows the logical partition parameter settings necessary for this example.

Table 5. Example Logical Partition Parameter Settings

Parameter	Setting
Current Logical Partition	0 (to define parameters for logical partition 0)
Memory	128M
Owner	OS
Maintenance	Online and concurrent maintenance enabled
Description	<i>Left at the default for this example</i>
CPUs	0 ,1, 2, and 3
Cluster Offset	1
Cluster Range	22 (selects clusters 1, 2, 3, 4, 5, 6, 7, 10, 11, 12, 13, 14, 15, 16, 17, 20, 21, and 22)
Auto BCD	<i>Left at the default for this example</i>
LOSPs	100/101, 102/103, 104/105, 106/107, 110/111, 112/113, 114/115, 116/117, and 060/061
HISPs	400, 401, 402, 403, 404, 405, 406, and 407
VHISPs	020, 021, 022, and 023

Figure 14 shows the SCE base window with the correct parameters for this example. Figure 15 shows the SCE T90: Miscellaneous Configuration window with the correct parameters for this example.

System Configuration Environment (SCET90 1.2.0) – SIM [techsun1] (76)
File ▾ Edit ▾ View ▾ Properties... Assume ▾ Apply ▾ Assert ▾ Reset ▾

System Type: T94
System Serial: 7001 ▾ ▾
System Memory: ▾ 128M
Physical Partitions: 1 2

Current Physical Partition: 0
Sanity Port: I/O A
Sparechips: Disabled Enabled
Logical Partitions: 1 2 3 4

Current Logical Partition: 0
Memory: 128M
Owner: OS Maintenance In Use
Maintenance: On-Line Enabled Concurrent Enabled
Description: PPO, LPQ

CPUs:

00	04	10	14	20	24	30	34
01	05	11	15	21	25	31	35
02	06	12	16	22	26	32	36
03	07	13	17	23	27	33	37

Cluster Offset: 1 ▾ ▾
Cluster Range: 22 ▾ ▾
Auto BCD: Off On

LOSPs:	HISPs:	VHISPs:
100/101	400	020
120/121	410	030
140/141	420	040
160/161	430	050
102/103	401	021
122/123	411	031
142/143	421	041
162/163	431	051
104/105	402	022
124/125	412	032
144/145	422	042
164/165	432	052
106/107	403	023
126/127	413	033
146/147	423	043
166/167	433	053
110/111	404	024
130/131	414	034
150/151	424	044
170/171	434	054
112/113	405	025
132/133	415	035
152/153	425	045
172/173	435	055
114/115	406	026
134/135	416	036
154/155	426	046
174/175	436	056
116/117	407	027
136/137	417	037
156/157	427	047
176/177	437	057
060/061	062/063	064/065
066/067		

New configuration – apply/assert required.

Figure 14. SCE Base Window Settings for a New CRAY T94 Configuration (Example)

Degrading Memory in a CRAY T932 Mainframe (with CM03 Modules)

This example shows you how to degrade memory by banks, by subsections, and by sections. This example degrades memory in a CRAY T932 mainframe (with CM03 modules) to use banks 0, 1, 2, 3, 4, 5, 6, and 7; subsections 0, 1, 2, and 3; and sections 4, 5, 6, and 7.

Figure 16 shows how this example adds 3 address bits to force bit 9 to a 0, bit 5 to a 0, and bit 2 to a 1. These settings degrade banks 10, 11, 12, 13, 14, 15, 16, and 17; subsections 4, 5, 6, and 7; and sections 0, 1, 2, and 3. These areas in memory are no longer used. After you perform these memory degradations, only banks 0, 1, 2, 3, 4, 5, 6, and 7; subsections 0, 1, 2, and 3; and sections 4, 5, 6, and 7 are used.

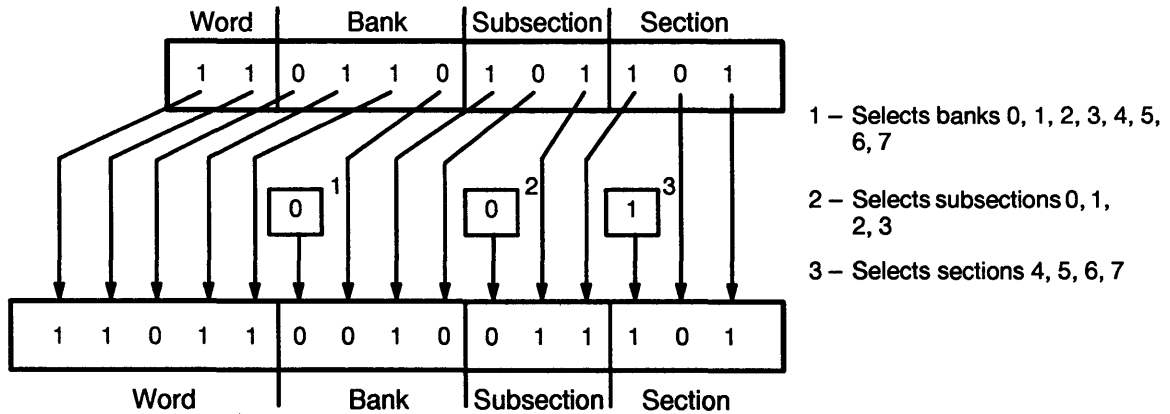


Figure 16. Example of Degrading Memory

Figure 17 shows the memory utilization map for this example.

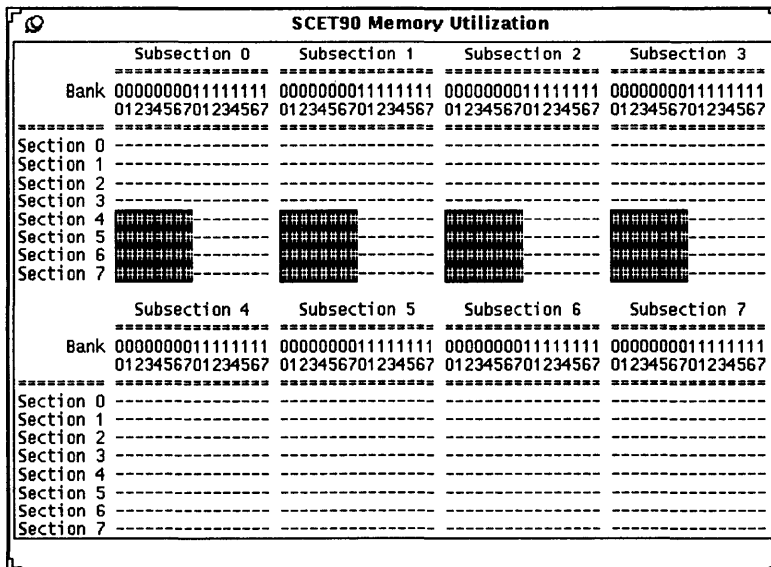


Figure 17. Example Memory Utilization Map

SCE provides two modes in the SCET90: Memory Configuration window that you can use to degrade memory: default mode and custom mode. Figure 18 on page 42 shows how to set the parameters for this example in default mode. Figure 19 on page 44 shows how to set the parameters for this example in custom mode.

Before you can perform any of the procedures shown in this subsection, you must open the SCET90 Memory window and view the memory degradation parameters. To do this, perform the following actions:

1. Choose **View → Memory** to open the SCET90 Memory Window.
2. Click on Configure: to select the memory degradation parameters.

Memory Degradation Example (with Memory Parameters in Default Mode)

Click on Degradate Mode: to set the parameters in default mode. Figure 18 shows the correct parameter settings in default mode for this example.

SCET90 Memory				
Configure:	<input type="button" value="Modules"/>	<input type="button" value="Degrades"/>	<input type="button" value="Partitions"/>	
Physical Partition:	<input type="text" value="0"/>			
Memory Type:	CM03 – Homogeneous			
Degrade Mode:	<input type="button" value="Default"/> <input type="button" value="Custom"/>			
Sections:	<input type="button" value="All"/> <input type="button" value="1/2"/>			
	<input type="text" value="0,1,2,3"/>			
	<input type="text" value="4,5,6,7"/>			
Subsections:	<input type="button" value="All"/> <input type="button" value="1/2"/> <input type="button" value="1/4"/> <input type="button" value="1/8"/>			
	<input type="text" value="0,2,4,6"/>	<input type="text" value="0,1,4,5"/>	<input type="text" value="0,1,2,3"/>	
	<input type="text" value="1,3,5,7"/>	<input type="text" value="2,3,6,7"/>	<input type="text" value="4,5,6,7"/>	
Banks:	<input type="button" value="All"/> <input type="button" value="1/2"/> <input type="button" value="1/4"/> <input type="button" value="1/8"/> <input type="button" value="1/16"/>			
	<input type="text" value="0,1,2,3,4,5,6,7"/>			
	<input type="text" value="10,11,12,13,14,15,16,17"/>			
	<input type="text" value="0,1,2,3,10,11,12,13"/>			
	<input type="text" value="4,5,6,7,14,15,16,17"/>			
	<input type="text" value="0,1,4,5,10,11,14,15"/>			
	<input type="text" value="2,3,6,7,12,13,16,17"/>			
	<input type="text" value="0,2,4,6,10,12,14,16"/>			
	<input type="text" value="1,3,5,7,11,13,15,17"/>			

Figure 18. Example Memory Parameters (in Default Mode)

The following procedures describe how you use the Sections, Subsections, and Banks settings in default mode for this example.

Degrading Memory by Banks (Using Default Mode)

1. Click on Banks: to specify that you want to use half of the available banks.
2. Click on to specify that you want to degrade memory by banks to use only banks 0, 1, 2, 3, 4, 5, 6, and 7.

Degrading Memory by Subsections (Using Default Mode)

1. Click on Subsections: to specify that you want to use half of the available subsections.
2. Click on to specify that you want to degrade memory by subsections to use only subsections 0, 1, 2, and 3.

Degrading Memory by Sections (Using Default Mode)

1. Click on Sections: to specify that you want to use half of the available sections.
2. Click on to specify that you want to degrade memory by sections to use only sections 4, 5, 6, and 7.

Memory Degradation Example (with Memory Parameters in Custom Mode)

Click on Degrade Mode: to set the parameters in custom mode. Figure 19 shows the correct parameter settings in custom mode for this example.

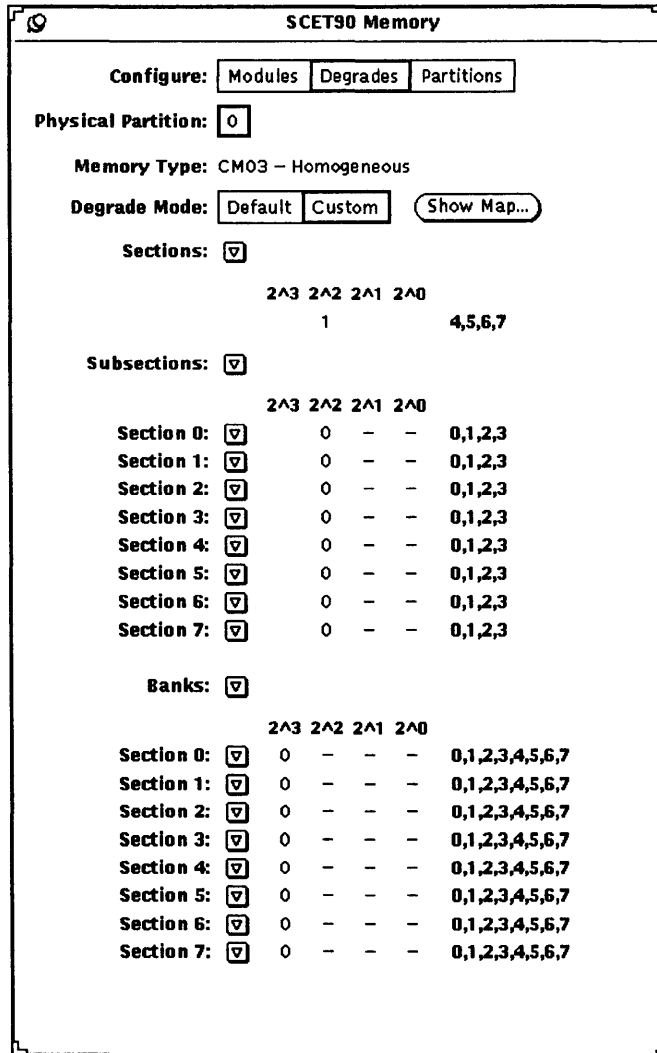


Figure 19. Example Memory Parameters (in Custom Mode)

The following procedures describe how to perform the memory degradations in custom mode for this example.

Degrading Memory by Banks (Using Custom Mode)

For this example, you can degrade memory by banks three different ways (the easiest way is shown first):

- Choose Banks: 8 of 16 → 0,1,2,3,4,5,6,7 to specify that you want to degrade memory to use only banks 0, 1, 2, 3, 4, 5, 6, and 7.
- In the Banks area of the window, for each section (Section 0 through Section 7), choose 8 of 16 → 0,1,2,3,4,5,6,7, to specify that you want to degrade memory to use only banks 0, 1, 2, 3, 4, 5, 6, and 7 for the section.
- In the Banks area of the window, set bit 2³ for each section to 0.

Degrading Memory by Subsections (Using Custom Mode)

For this example, you can degrade memory by subsections three different ways (the easiest way is shown first):

- Choose Subsections: 4 of 8 → 0,1,2,3 to specify that you want to degrade memory to use only subsections 0, 1, 2, and 3.
- In the Subsections area of the window, for each section (Section 0 through Section 7), choose 4 of 8 → 0,1,2,3 to specify that you want to degrade memory to use only subsections 0, 1, 2, and 3 for the section.
- In the Subsections area of the window, set bit 2² for each section to 0.

Degrading Memory by Sections (Using Custom Mode)

For this example, you can degrade memory by sections two different ways:

- Choose Sections: 4 of 8 → 4,5,6,7 to specify that you want to degrade memory to use only banks 4, 5, 6, and 7.
- In the Sections area of the window, set bit 2² to 1.

Degrading Memory in a CRAY T916 Mainframe (with CM02 Modules)

This example shows how to degrade memory by banks in a CRAY T916 mainframe (with CM02 memory modules) to use only the upper banks. Table 6 shows the section-to-bank mappings for the full configuration and the degraded configuration used in this example.

Table 6. Example Section-to-bank Mappings

Section	Banks	
	Full Configuration	Degraded Configuration
0	0, 1, 4, 5	4, 5
1	0, 1, 4, 5	4, 5
2	2, 3, 6, 7	6, 7
3	2, 3, 6, 7	6, 7
4	0, 1, 4, 5	4, 5
5	0, 1, 4, 5	4, 5
6	2, 3, 6, 7	6, 7
7	2, 3, 6, 7	6, 7

This example shows how to degrade memory in default mode and in custom mode.

Using Default Mode

In default mode, click on Banks: 1/2 and then click on 4,5,6,7. SCE automatically configures the mainframe to use the section-to-bank mappings shown in the “Degraded Configuration” column of Table 6.

Using Custom Mode

In custom mode, perform the following steps in the Banks portion of the SCE T90: Memory Configuration window (Figure 20 shows a window with the correct settings for this example):

1. Choose Section 0: 2 of 16 → 4,5 to map section 0 to banks 4 and 5.
2. Choose Section 1: 2 of 16 → 4,5 to map section 1 to banks 4 and 5.

3. Choose Section 2: 2 of 16 → 6,7 to map section 2 to banks 6 and 7.
4. Choose Section 3: 2 of 16 → 6,7 to map section 3 to banks 6 and 7.
5. Choose Section 4: 2 of 16 → 4,5 to map section 4 to banks 4 and 5.
6. Choose Section 5: 2 of 16 → 4,5 to map section 5 to banks 4 and 5.
7. Choose Section 6: 2 of 16 → 6,7 to map section 6 to banks 6 and 7.
8. Choose Section 7: 2 of 16 → 6,7 to map section 7 to banks 6 and 7.

Banks:	<input type="checkbox"/>					
		2 [^] 3	2 [^] 2	2 [^] 1	2 [^] 0	
Section 0:	<input type="checkbox"/>	0	1	0	-	4,5
Section 1:	<input type="checkbox"/>	0	1	0	-	4,5
Section 2:	<input type="checkbox"/>	0	1	1	-	6,7
Section 3:	<input type="checkbox"/>	0	1	1	-	6,7
Section 4:	<input type="checkbox"/>	0	1	0	-	4,5
Section 5:	<input type="checkbox"/>	0	1	0	-	4,5
Section 6:	<input type="checkbox"/>	0	1	1	-	6,7
Section 7:	<input type="checkbox"/>	0	1	1	-	6,7

Figure 20. Bank Memory Parameters (Example)

Setting up a Partition for Maintenance

This example shows how to create a logical partition in which you can run maintenance software while another partition of the mainframe continues to run the operating system. Table 7 shows the physical components that each logical partition contains.

Table 7. Example Configuration Components

Partition	Memory	CPUs	Clusters	Channels
Logical partition 0 (OS owner)	64 Mwords	0, 1	1, 2, 3, 4, 5, 6, 7, 10, 11 (octal)	LOSP: 100/101 102/103 104/105 106/107 060/061 HISP: 400 401 402 403 VHISP: 020 021
Logical partition 1 (Maintenance owner)	64 Mwords	2, 3	12, 13, 14, 15, 16, 17, 20, 21, 22 (octal)	LOSP: 110/111 112/113 114/115 116/117 HISP: 404 405 406 407 VHISP: 022 023

The following procedures indicate the steps you need to perform to create this example configuration:

1. Modify the system information parameters to indicate the serial number, amount of system memory, and number of physical partitions.

Table 8 and Figure 21 show the system information parameter settings necessary for this example.

Table 8. System Information Parameter Settings (Example)

Parameter	Setting
System Type	T94
System Serial	7001
System Memory	128M
Physical Partitions	1 (for CRAY T94 mainframe)

System Type: T94

System Serial: 7001

System Memory: 128M

Physical Partitions:

Figure 21. System Information Parameters (Example)

2. Set up the configuration information for the current physical partition.

Table 9 and Figure 22 show the physical partition parameter settings for this example.

Table 10. Logical Partition 0 Parameter Settings (Example)

Parameter	Setting
Current Logical Partition	0 (to define parameters for logical partition 0)
Memory	64 Mwords (SCE divided memory in half and configured half to each of the two logical partitions)
Owner	OS
Maintenance	Online and concurrent maintenance enabled
Description	<i>Left at the default for this example</i>
CPUs	0 and 1
Cluster Offset	1
Cluster Range	11 ₈ (selects clusters 1, 2, 3, 4, 5, 6, 7, 10, and 11)
Auto BCD	<i>Left at the default for this example</i>
LOSPs	100/101, 102/103, 104/105, 106/107 060/061
HISPs	400, 401, 402, 403
VHISPs	020, 021

Current Logical Partition:

Memory: 64M

Owner:

Maintenance:

Description: PPO, LPQ

CPUs:

00	04	08	12	16	20	24	28	32	36
01	05	11	15	21	25	31	35		
02	06	10	14	18	22	26	30	34	38
03	07	13	17	23	27	33	37		

Cluster Offset: 1

Cluster Range: 11

Auto BCD:

LOSPs:

100/101	120/121	140/141	160/161
102/103	122/123	142/143	162/163
104/105	124/125	144/145	164/165
106/107	126/127	146/147	166/167
110/111	130/131	150/151	170/171
112/113	132/133	152/153	172/173
114/115	134/135	154/155	174/175
116/117	136/137	156/157	176/177
060/061	062/063	064/065	066/067

HISPs:

400	410	420	430
401	411	421	431
402	412	422	432
403	413	423	433
404	414	424	434
405	415	425	435
406	416	426	436
407	417	427	437

VHISPs:

020	030
021	031
022	032
023	033
024	034
025	035
026	036
027	037

New configuration – apply/assert required.

Figure 23. Logical Partition 0 Parameters (Example)

Table 11 and Figure 24 show the logical partition parameter settings for logical partition 1.

NOTE: To switch to logical partition 1, click on Current Logical Partition: .

Table 11. Logical Partition 1 Parameter Settings (Example)

Parameter	Setting
Current Logical Partition	1 (to define parameters for logical partition 1)
Memory	64 Mwords (SCE divided memory in half and configured half to each of the two logical partitions)
Owner	Maintenance
Description	<i>Left at the default for this example</i>
CPUs	2 and 3
Cluster Offset	12
Cluster Range	11 ₈ (selects clusters 12, 13, 14, 15, 16, 17, 20, 21, 22)
Auto BCD	<i>Left at the default for this example</i>
LOSPs	110/111, 112/113, 114/115, 116/117
HISPs	404, 405, 406, 407
VHISPs	022, 023

Current Logical Partition: 0 1

Memory: 64M

Owner: OS Maintenance In Use

Maintenance: On-Line Enabled Concurrent Enabled

Description: PPO, LP1

CPUs:

00	04	10	14	20	24	30	34
01	05	11	15	21	25	31	35
02	06	12	16	22	26	32	36
03	07	13	17	23	27	33	37

Cluster Offset: 12

Cluster Range: 11

Auto BCD: Off On

LOSPs:

100/101	120/121	140/141	160/161
102/103	122/123	142/143	162/163
104/105	124/125	144/145	164/165
106/107	126/127	146/147	166/167
110/111	130/131	150/151	170/171
112/113	132/133	152/153	172/173
114/115	134/135	154/155	174/175
116/117	136/137	156/157	176/177
060/061	062/063	064/065	066/067

HISPs:

400	410	420	430
401	411	421	431
402	412	422	432
403	413	423	433
404	414	424	434
405	415	425	435
406	416	426	436
407	417	427	437

VHISPs:

020	030
021	031
022	032
023	033
024	034
025	035
026	036
027	037

New configuration - apply/assert required.

Figure 24. Logical Partition 1 Parameters (Example)

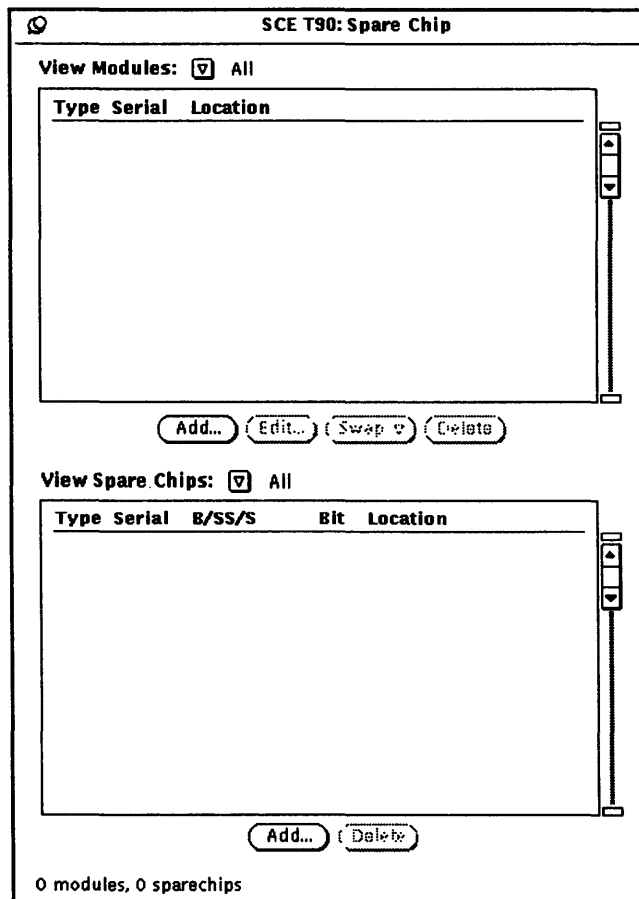
Flawing a Bad Memory Chip

The following example shows how to enter the bad bit information shown in Table 12 so that SCE will replace the flawed chip with a spare chip.

Table 12. Bad Bit Location Information

Component	Value
Module location	In a CRAY T94 mainframe [serial number 7001 (slot C5)]
Module	CM02 module (serial number 117)
Bank	3
Subsection	0
Section	7
Bad bit	51

1. Choose **View** → **Spare Chip** in the SCE base window. The SCE T90: Spare Chip window appears:



2. In the SCE T90: Spare Chip window, click on **Add...** (located below the View Modules scroll box) to add a module entry to the table. SCE displays the SCE T90: Module Add window:

The screenshot shows a dialog box titled "SCET90: Module Add". It contains the following fields and controls:

- Module Serial:** A text input field containing "0" and a small dropdown arrow icon.
- Module Type:** Two buttons labeled "CM02" and "CM03".
- Module Location:** Two buttons labeled "Spare" and "Mainframe".
- Mainframe Type:** Four buttons labeled "Tester", "T94", "T916", and "T932".
- Mainframe Serial:** A text input field containing "0" and a small dropdown arrow icon.
- Mainframe Slot:** Four buttons labeled "C2", "C3", "C4", and "C5".
- Apply:** A button at the bottom center of the dialog.

3. In the Module Serial field, enter **117** (the serial number of the module in this example).
4. Click on Module Type: **CM02**.
5. Perform the following actions to enter the module location information for this example:
 - a. Click on Module Location: **Mainframe**.
 - b. Click on Mainframe Type: **T94**.
 - c. Enter **7001** in the Mainframe Serial field.
 - d. Click on Mainframe Slot: **C5**.

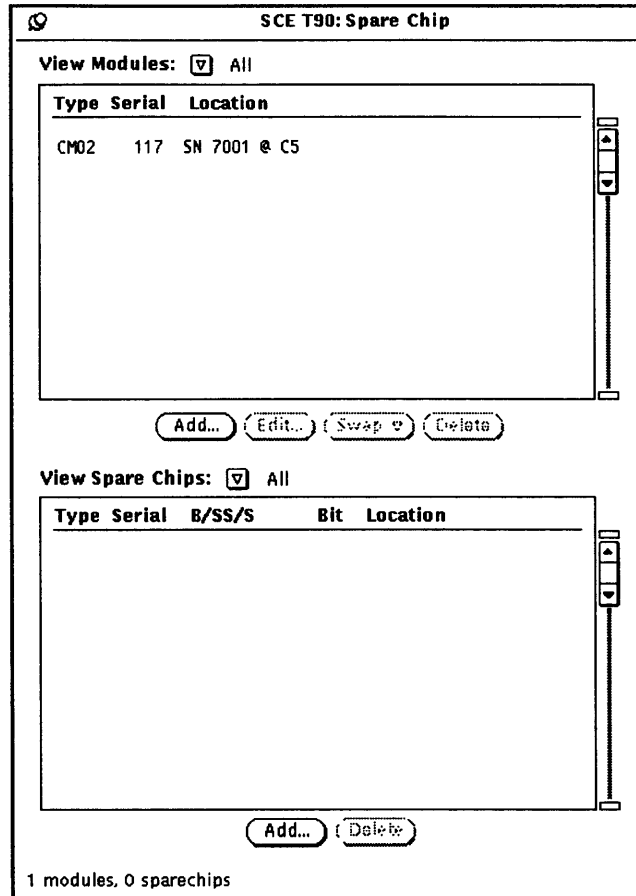
The following snap shows the SCE T90: Module Add window with the correct values for this example:

The screenshot displays a window titled "SCET90: Module Add". It contains the following fields and options:

- Module Serial:** 117 (with a dropdown arrow)
- Module Type:** CM02, CM03
- Module Location:** Spare, Mainframe
- Mainframe Type:** Tester, T94, T916, T932
- Mainframe Serial:** 7001 (with a dropdown arrow)
- Mainframe Slot:** C2, C3, C4, C5

An "Apply" button is located at the bottom center of the window.

6. In the SCE T90: Module Add window, click on **Apply** to insert the module information into the table. SCE adds the module information to the View Modules scroll box in the SCE T90: Spare Chip window, as shown in the following snap:



7. In the SCE T90: Spare Chip window, click on **Add...** (located below the View Spare Chips scroll box) to add a flaw-chip entry to the table. SCE displays the SCE T90: Spare Chip Add window:

SCET90: Spare Chip Add

Location:

Bank:

0	1	2	3	4	5	6	7
10	11	12	13	14	15	16	17

Subsection:

0	1	2	3	4	5	6	7
---	---	---	---	---	---	---	---

Section:

0	1	2	3	4	5	6	7
---	---	---	---	---	---	---	---

Bad Bit:

0	1	2	3	4	5	6	7	8	9
10	11	12	13	14	15	16	17	18	19
20	21	22	23	24	25	26	27	28	29
30	31	32	33	34	35	36	37	38	39
40	41	42	43	44	45	46	47	48	49
50	51	52	53	54	55	56	57	58	59
60	61	62	63	64	65	66	67	68	69
70	71	72	73	74	75				

Add

8. In the SCE T90: Spare Chip Add window, from the Location: , choose **Mainframe** → **SN 7001** to indicate that the bad chip is on a module in the mainframe.
9. Click on Bank: .

NOTE: The subsection parameter does not apply to CRAY T94 mainframes because they do not have subsections.

10. Click on Section: .
11. Click on Bad Bit: .

The following snap shows the SCE T90: Spare Chip Add window with the correct values for this example:

SCET90: Spare Chip Add

Location: Mainframe SN 7001

Bank:

0	1	2	3	4	5	6	7
10	11	12	13	14	15	16	17

Subsection:

0	1	2	3	4	5	6	7
---	---	---	---	---	---	---	---

Section:

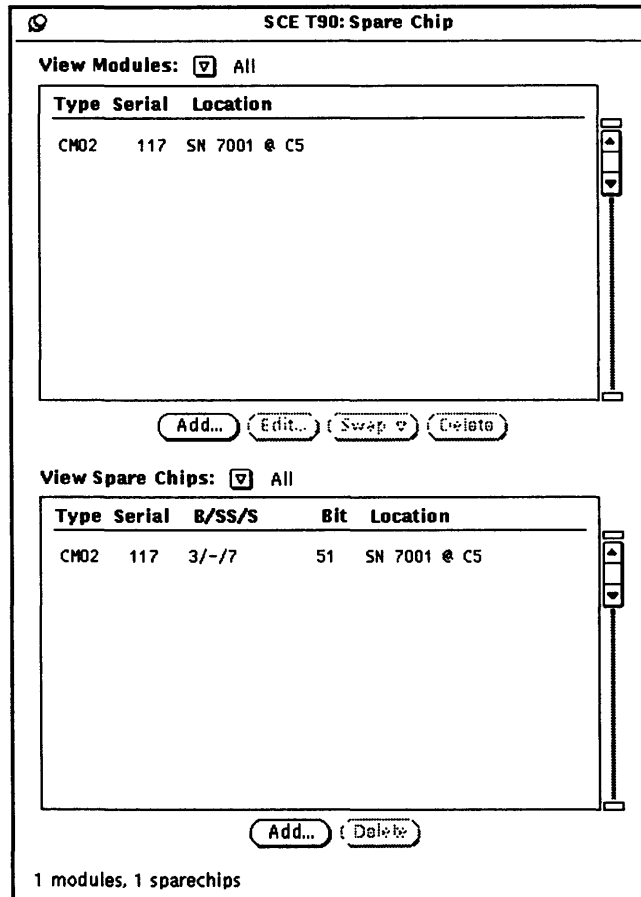
0	1	2	3	4	5	6	7
---	---	---	---	---	---	---	---

Bad Bit:

0	1	2	3	4	5	6	7	8	9
10	11	12	13	14	15	16	17	18	19
20	21	22	23	24	25	26	27	28	29
30	31	32	33	34	35	36	37	38	39
40	41	42	43	44	45	46	47	48	49
50	51	52	53	54	55	56	57	58	59
60	61	62	63	64	65	66	67	68	69
70	71	72	73	74	75				

Add

12. In the SCE T90: Spare Chip Add window, click on **Add** to insert the flawed-chip information into the table. SCE adds the failing chip information to the View Spare Chips scroll box in the SCE T90: Spare Chip window:



SCE will substitute a spare chip for the flawed chip the next time you apply the configuration if the spare chip option is enabled for the physical partition that contains the flawed chip.

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